

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
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		Examiner	Art Unit	Page 1 of 1
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*	B	US-2003/0147030	08-2003	Sone, Takehiko	349/113
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	F	US-			
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	I	US-			
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	K	US-			
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	M	US-			

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NON-PATENT DOCUMENTS

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